

# **Complementary Darlington Silicon Power Transistors**

... designed for use as general purpose amplifiers, low frequency switching and motor control applications.

• High DC Current Gain @ 10 Adc —

$$h_{FE} = 400 \text{ Min (All Types)}$$

• Collector–Emitter Sustaining Voltage

• Low Collector-Emitter Saturation Voltage

$$V_{CE(sat)} = 1.2 \text{ V (Typ)} @ I_C = 5.0 \text{ A}$$
  
= 1.8 V (Typ) @ I\_C = 10 A

• Monolithic Construction

#### **MAXIMUM RATINGS**

		MJH			
Rating	Symbol	11018 11017	11020 11019	11022 11021	Unit
Collector–Emitter Voltage	V <sub>CEO</sub>	150	200	250	Vdc
Collector-Base Voltage	V <sub>CB</sub>	150	200	250	Vdc
Emitter-Base Voltage	V <sub>EB</sub>	5.0			Vdc
Collector Current — Continuous — Peak (1)	I <sub>C</sub>	15 30		Adc	
Base Current	I <sub>B</sub>	0.5			Adc
Total Device Dissipation @ T <sub>C</sub> = 25°C Derate Above 25°C	P <sub>D</sub>	150 1.2		Watts W/°C	
Operating and Storage Junction Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-65 to +150		°C	

#### THERMAL CHARACTERISTICS

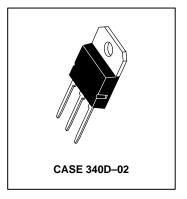
Characteristic	Symbol	Max	Unit
Thermal Resistance. Junction to Case	$R_{ heta JC}$	0.83	°C/W

<sup>(1)</sup> Pulse Test: Pulse Width = 5.0 ms, Duty Cycle  $\leq 10\%$ .

MJH11017\*
MJH11019\*
MJH11021\*
MJH11018\*
MJH11020\*
MJH11022\*

\*ON Semiconductor Preferred Device

15 AMPERE DARLINGTON COMPLEMENTARY SILICON POWER TRANSISTORS 150, 200, 250 VOLTS 150 WATTS



Preferred devices are ON Semiconductor recommended choices for future use and best overall value.

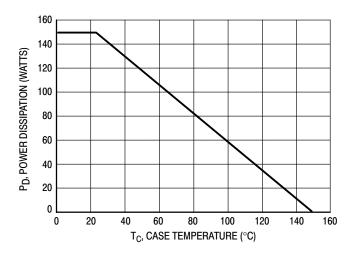


Figure 1. Power Derating

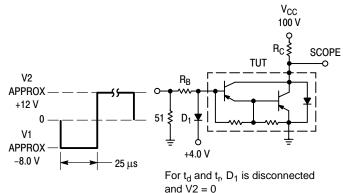
# **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit	
OFF CHARACTERISTICS				1	1
Collector–Emitter Sustaining Voltage (1) $(I_C = 0.1 \text{ Adc}, I_B = 0)$	MJH11017, MJH11018 MJH11019, MJH11020 MJH11021, MJH11022	V <sub>CEO(sus)</sub>	150 200 250	_ _ _	Vdc
Collector Cutoff Current $(V_{CE} = 75 \text{ Vdc}, I_B = 0)$ $(V_{CE} = 100 \text{ Vdc}, I_B = 0)$ $(V_{CE} = 125 \text{ Vdc}, I_B = 0)$	MJH11017, MJH11018 MJH11019, MJH11020 MJH11021, MJH11022	I <sub>CEO</sub>		1.0 1.0 1.0	mAdc
Collector Cutoff Current $(V_{CE} = Rated \ V_{CB}, \ V_{BE(off)} = 1.5 \ Vdc)$ $(V_{CE} = Rated \ V_{CB}, \ V_{BE(off)} = 1.5 \ Vdc, \ T_{J} = 150 ^{\circ}C$	:)	I <sub>CEV</sub>	_	0.5 5.0	mAdc
Emitter Cutoff Current (V <sub>BE</sub> = 5.0 Vdc I <sub>C</sub> = 0)		I <sub>EBO</sub>	_	2.0	mAdc
ON CHARACTERISTICS (1)					
DC Current Gain ( $I_C = 10$ Adc, $V_{CE} = 5.0$ Vdc) ( $I_C = 15$ Adc, $V_{CE} = 5.0$ Vdc)		h <sub>FE</sub>	400 100	15,000 —	_
Collector–Emitter Saturation Voltage ( $I_C = 10$ Adc, $I_B = 100$ mA) ( $I_C = 15$ Adc, $I_B = 150$ mA)		V <sub>CE(sat)</sub>	_	2.5 4.0	Vdc
Base–Emitter On Voltage (I <sub>C</sub> = 10 A, V <sub>CE</sub> = 5.0 Vdc)		V <sub>BE(on)</sub>	_	2.8	Vdc
Base–Emitter Saturation Voltage (I <sub>C</sub> = 15 Adc, I <sub>B</sub> = 150 mA)		V <sub>BE(sat)</sub>	_	3.8	Vdc
DYNAMIC CHARACTERISTICS					
Current–Gain Bandwidth Product (I <sub>C</sub> = 10 Adc, V <sub>CE</sub> = 3.0 Vdc, f = 1.0 MHz)		f <sub>T</sub>	3.0	_	_
• •	H11018, MJH11020, MJH11022 H11017, MJH11019, MJH11021	C <sub>ob</sub>	_	400 600	pF
Small–Signal Current Gain (I <sub>C</sub> = 10 Adc, V <sub>CE</sub> = 3.0 Vdc, f = 1.0 kHz)		h <sub>fe</sub>	75		
SWITCHING CHARACTERISTICS					

			Typical		
Characteristic		Symbol	NPN	PNP	Unit
Delay Time		t <sub>d</sub>	150	75	ns
Rise Time	$(V_{CC} = 100 \text{ V}, I_{C} = 10 \text{ A}, I_{B} = 100 \text{ mA}$ $V_{BE(off)} = 5.0 \text{ V}) \text{ (See Figure 2)}$	t <sub>r</sub>	1.2	0.5	μs
Storage Time		t <sub>s</sub>	4.4	2.7	μs
Fall Time		t <sub>f</sub>	2.5	2.5	μs

<sup>(1)</sup> Pulse Test: Pulse Width = 300  $\mu s$ , Duty Cycle  $\leq$  2.0%.

 $R_B$  &  $R_C$  varied to obtain desired current levels  $D_1$ , must be fast recovery types, e.g.: 1N5825 used above  $I_B \approx 100$  mA MSD6100 used below  $I_B \approx 100$  mA



 $t_r$ ,  $t_f \le 10 \text{ ns}$ Duty Cycle = 1.0%

For NPN test circuit, reverse diode and voltage polarities.

Figure 2. Switching Times Test Circuit

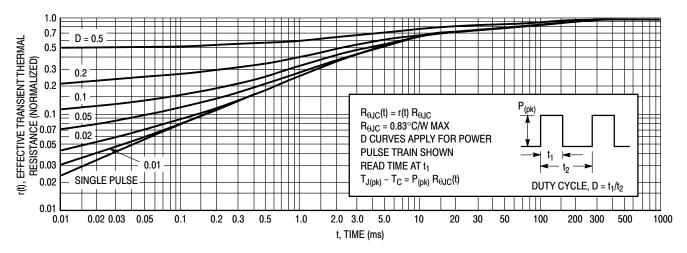


Figure 3. Thermal Response

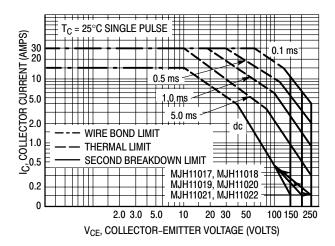


Figure 4. Maximum Rated Forward Bias Safe Operating Area (FBSOA)

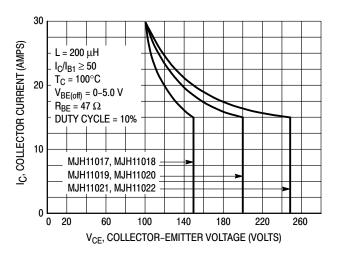


Figure 5. Maximum Rated Reverse Bias Safe Operating Area (RBSOA)

#### **FORWARD BIAS**

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate  $I_C-V_{CE}$  limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 4 is based on  $T_{J(pk)} = 150^{\circ}C$ ;  $T_C$  is variable depending on conditions. Second breakdown pulse limits are valid for duty cycles to 10% provided  $T_{J(pk)} \le 150^{\circ}C$ .  $T_{J(pk)}$  may be calculated from the data in Figure 3. At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

#### **REVERSE BIAS**

For inductive loads, high voltage and high current must be sustained simultaneously during turn-off, in most cases, with the base to emitter junction reverse biased. Under these conditions the collector voltage must be held to a safe level at or below a specific value of collector current. This can be accomplished by several means such as active clamping, RC snubbing, load line shaping, etc. The safe level for these devices is specified as Reverse Bias Safe Operating Area and represents the voltage-current conditions during reverse biased turn-off. This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode. Figure 5 gives RBSOA characteristics.

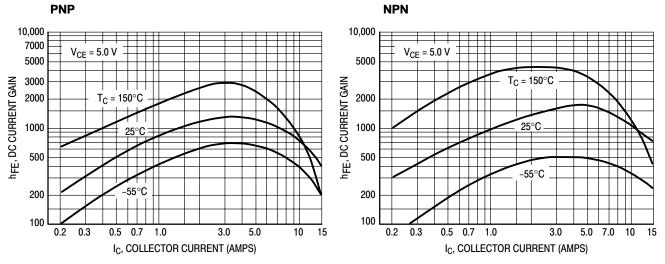


Figure 6. DC Current Gain

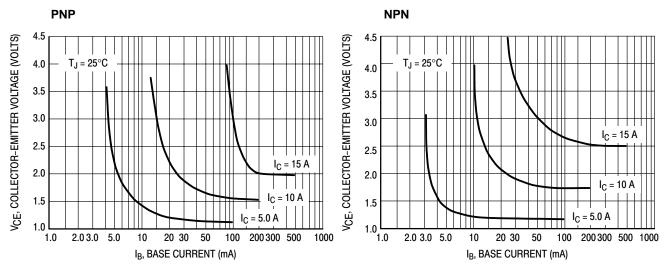


Figure 7. Collector Saturation Region

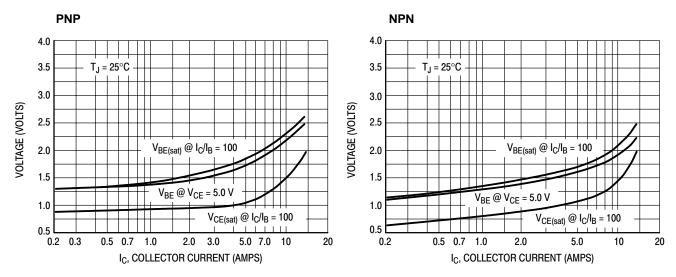


Figure 8. "On" Voltages

PNP NPN

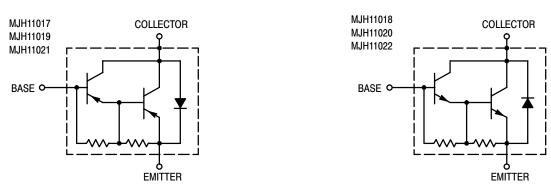
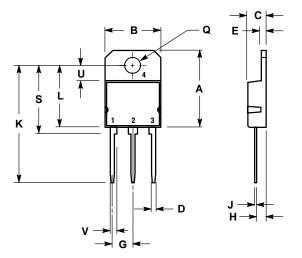


Figure 9. Darlington Schematic

# **PACKAGE DIMENSIONS**

# CASE 340D-02 **ISSUE E**



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: MILLIMETER.

	MILLIMETERS		INCHES		
DIM	MIN	MAX	MIN	MAX	
Α		20.35		0.801	
В	14.70	15.20	0.579	0.598	
С	4.70	4.90	0.185	0.193	
D	1.10	1.30	0.043	0.051	
E	1.17	1.37	0.046	0.054	
G	5.40	5.55	0.213	0.219	
Н	2.00	3.00	0.079	0.118	
J	0.50	0.78	0.020	0.031	
K	31.00	31.00 REF		REF	
L		16.20		0.638	
Q	4.00	4.10	0.158	0.161	
S	17.80	18.20	0.701	0.717	
U	4.00	REF	0.157 REF		
V	1.75 REF		0.069		

STYLE 1:

- PIN 1. BASE
  2. COLLECTOR
  3. EMITTER
  4. COLLECTOR

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